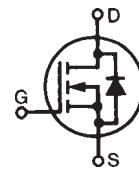


HiPerFET™
Power MOSFET
Q2-Class

IXFN70N60Q2



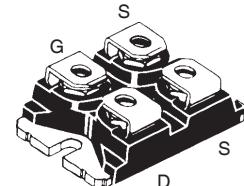
V_{DSS} = 600V
I_{D25} = 70A
R_{DS(on)} ≤ 80mΩ
t_{rr} ≤ 250ns

N-Channel Enhancement Mode
Avalanche Rated, Low Q_g, Low Intrinsic R_g
High dV/dt, Low t_{rr}

Symbol	Test Conditions	Maximum Ratings		
V _{DSS}	T _J = 25°C to 150°C	600	V	
V _{DGR}	T _J = 25°C to 150°C, R _{GS} = 1MΩ	600	V	
V _{GSS}	Continuous	±30	V	
V _{GSM}	Transient	±40	V	
I _{D25}	T _C = 25°C	70	A	
I _{DM}	T _C = 25°C, pulse width limited by T _{JM}	280	A	
I _A	T _C = 25°C	70	A	
E _{AS}	T _C = 25°C	5	J	
dV/dt	I _S ≤ I _{DM} , V _{DD} ≤ V _{DSS} , T _J ≤ 150°C	20	V/ns	
P _D	T _C = 25°C	890	W	
T _J		-55 ... +150	°C	
T _{JM}		150	°C	
T _{stg}		-55 ... +150	°C	
T _L	1.6mm (0.062 in.) from case for 10s	300	°C	
V _{ISOL}	50/60Hz, RMS t = 1min	2500	V~	
	I _{ISOL} ≤ 1mA t = 1s	3000	V~	
M _d	Mounting torque	1.5/13	Nm/lb.in.	
	Terminal connection torque	1.3/ 11.5	Nm/lb.in.	
Weight		30	g	

Symbol	Test Conditions (T _J = 25°C, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
BV _{DSS}	V _{GS} = 0V, I _D = 1mA	600		V
V _{GS(th)}	V _{DS} = V _{GS} , I _D = 8mA	3.0		V
I _{GSS}	V _{GS} = ±30V, V _{DS} = 0V		±200	nA
I _{DSS}	V _{DS} = V _{DSS} V _{GS} = 0V		50	μA
		T _J = 125°C	3	mA
R _{DS(on)}	V _{GS} = 10V, I _D = 0.5 • I _{D25} , Note 1		80	mΩ

miniBLOC, SOT-227 B (IXFN)
 E153432



G = Gate D = Drain
S = Source

Either Source terminal at miniBLOC can be used as Main or Kelvin Source

Features

- Double metal process for low gate resistance
- miniBLOC, with Aluminium nitride isolation
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
- Fast intrinsic Rectifier

Applications

- DC-DC converters
- Switched-mode and resonant-mode power supplies
- DC choppers
- Pulse generators

Advantages

- Easy to mount
- Space savings
- High power density

Symbol	Test Conditions (T _J = 25°C, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
g_{fs}	V _{DS} = 10V, I _D = 0.5 • I _{D25} , Note 1	36	50	S
C_{iss}	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz	12	nF	
C_{oss}		1340	pF	
C_{rss}		345	pF	
t_{d(on)}	Resistive Switching Times V _{GS} = 10V, V _{DS} = 0.5 • V _{DSS} , I _D = 0.5 • I _{D25} R _G = 1Ω (External)	26	ns	
t_r		25	ns	
t_{d(off)}		60	ns	
t_f		12	ns	
Q_{g(on)}	V _{GS} = 10V, V _{DS} = 0.5 • V _{DSS} , I _D = 0.5 • I _{D25}	265	nC	
Q_{gs}		57	nC	
Q_{gd}		120	nC	
R_{thJC}			0.14 °C/W	
R_{thCS}		0.05		°C/W

Source-Drain Diode

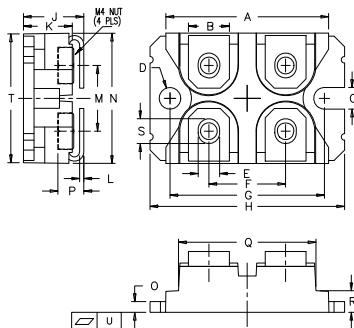
Symbol	Test Conditions (T _J = 25°C, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
I _s	V _{GS} = 0V		70	A
I _{SM}	Repetitive, pulse width limited by T _{JM}		280	A
V _{SD}	I _F = I _S , V _{GS} = 0V, Note 1		1.5	V
t_{rr}	I _F = 25A, -di/dt = 100A/μs V _R = 100V, V _{GS} = 0V		250	ns
Q_{RM}		1.2		μC
I_{RM}		8.0		A

Notes1: Pulse test, t ≤ 300μs; duty cycle, d ≤ 2%.

Ordering Information

The IXFN70N60Q2 is also available with brass capture nuts in place of the normal Zinc coated steel capture nuts. The ordering part number is IXFN70N60Q2-BN.

SOT-227B Outline

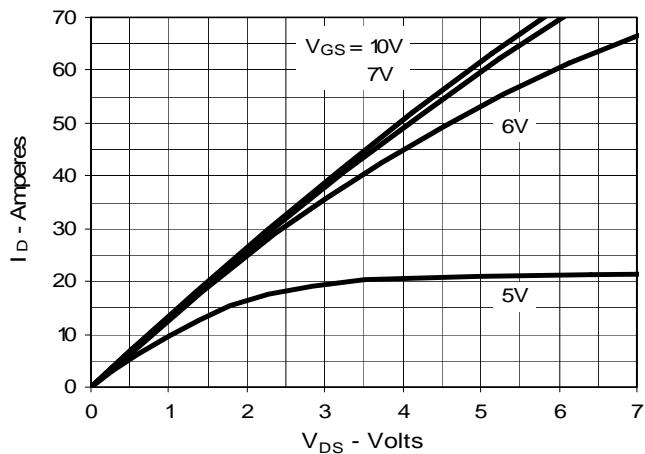


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.240	1.255	31.50	31.88
B	.307	.323	7.80	8.20
C	.161	.169	4.09	4.29
D	.161	.169	4.09	4.29
E	.161	.169	4.09	4.29
F	.587	.595	14.91	15.11
G	1.186	1.193	30.12	30.30
H	1.496	1.505	38.00	38.23
J	.460	.481	11.68	12.22
K	.351	.378	8.92	9.60
L	.030	.033	0.76	0.84
M	.496	.506	12.60	12.85
N	.990	1.001	25.15	25.42
O	.078	.084	1.98	2.13
P	.195	.235	4.95	5.97
Q	1.045	1.059	26.54	26.90
R	.155	.174	3.94	4.42
S	.186	.191	4.72	4.85
T	.968	.987	24.59	25.07
U	-.002	.004	-0.05	0.1

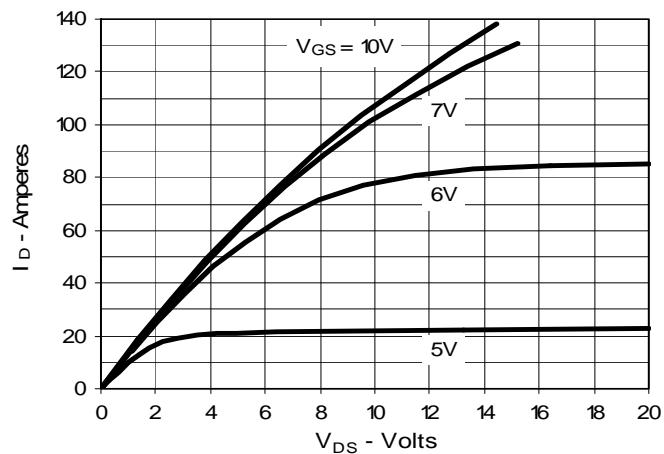
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

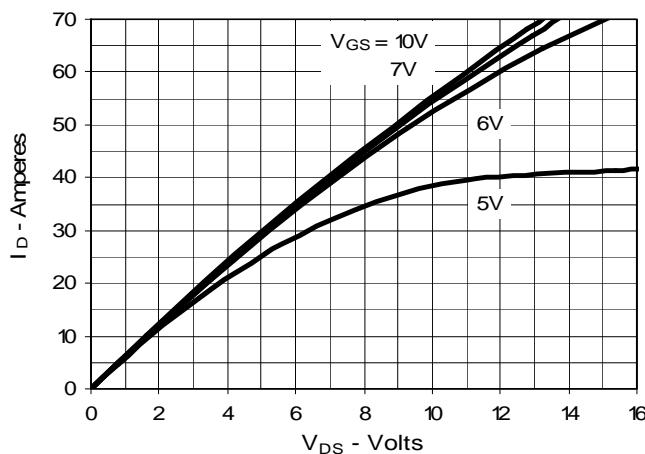
**Fig. 1. Output Characteristics
@ 25°C**



**Fig. 2. Extended Output Characteristics
@ 25°C**



**Fig. 3. Output Characteristics
@ 125°C**



**Fig. 4. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value vs.
Junction Temperature**

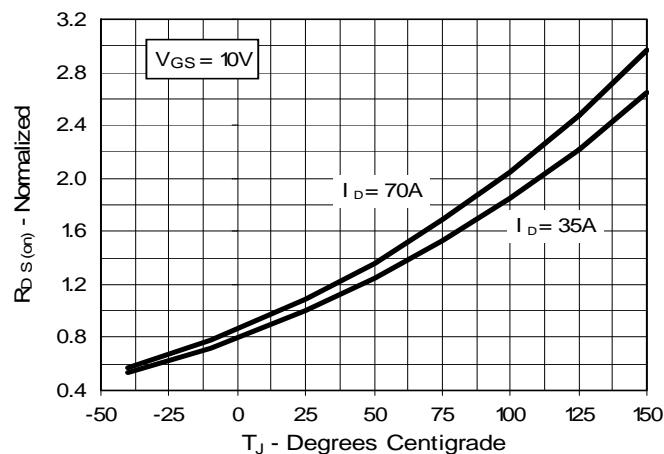


Fig. 5. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value vs. I_D

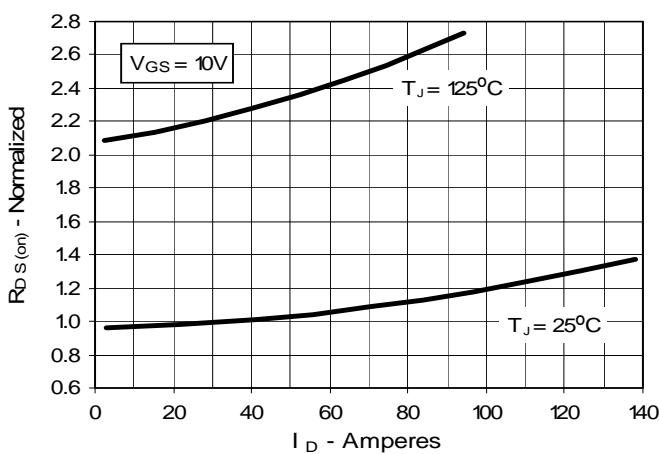


Fig. 6. Drain Current vs. Case Temperature

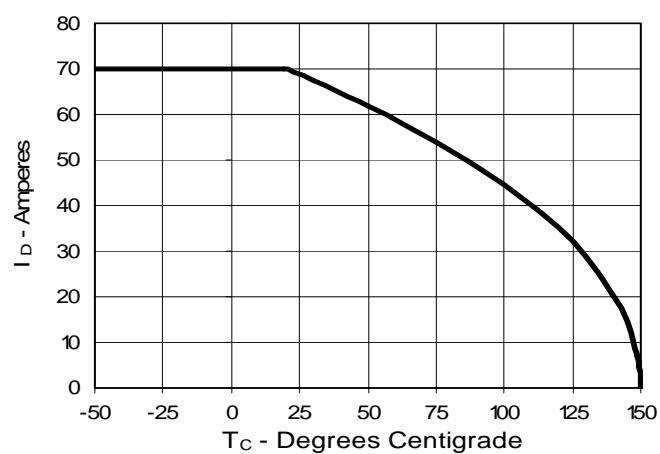


Fig. 7. Input Admittance

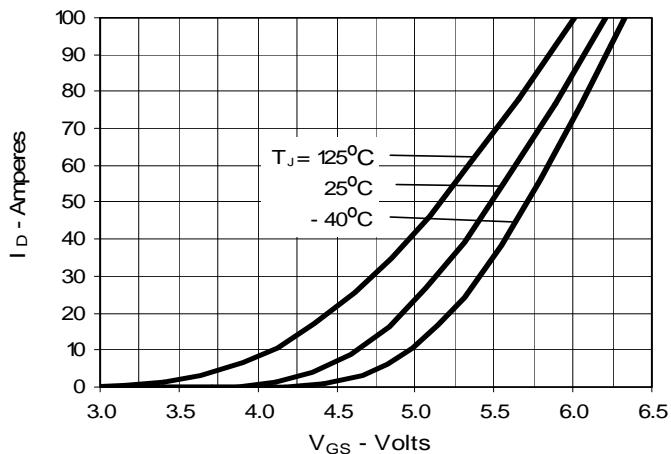


Fig. 8. Transconductance

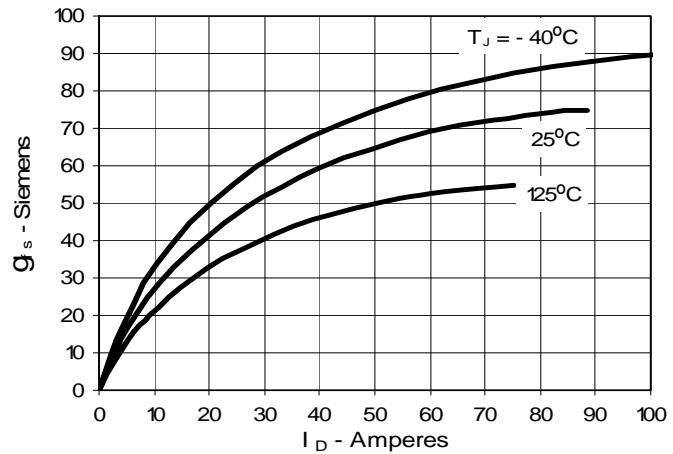


Fig. 9. Source Current vs. Source-To-Drain Voltage

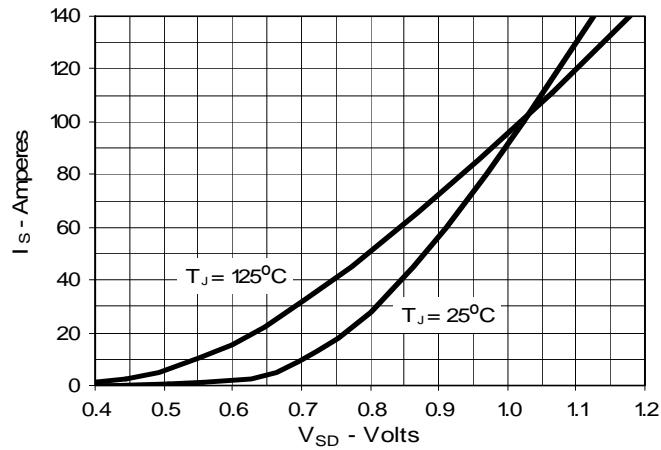


Fig. 10. Gate Charge

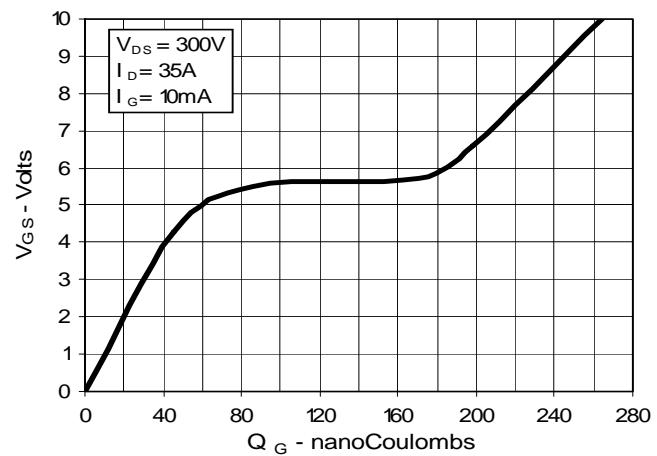


Fig. 11. Capacitance

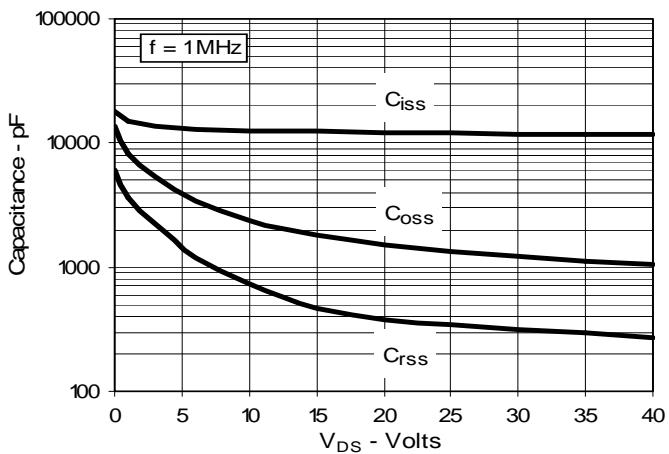


Fig. 12. Maximum Transient Thermal Impedance

